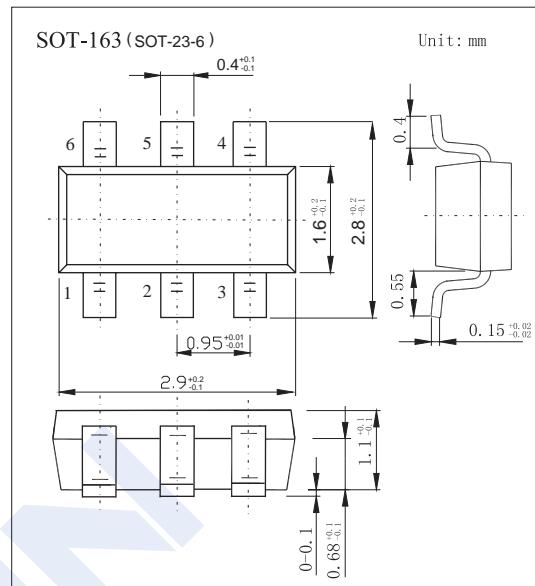
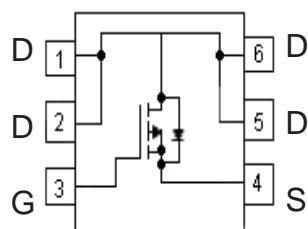


P-Channel MOSFET

2KJ6068

■ Features

- $V_{DS}(V) = -60V$
- $I_D = -6.5 A$
- $R_{DS(ON)} = 50m\Omega @ V_{GS} = -10V$
- $R_{DS(ON)} = 60m\Omega @ V_{GS} = -4.5V$

■ Absolute Maximum Ratings ($T_A = 25^\circ C$, unless otherwise noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-60	V
Gate-Source Voltage	V_{GS}	± 20	
Continuous Drain Current	I_D	-6.5	A
		-4.5	
		-3.8 ^{a,b}	
		-3.1 ^{a,b}	
Pulsed Drain Current	I_{DM}	-20	
Continuous Drain Current	I_S	-3.5	
		-1.7 ^{a,b}	
Avalanche Current	I_{AS}	-15	mJ
Single Pulse Avalanche Energy	E_{AS}	11.25	
Maximum Power Dissipation	P_D	4.2	
		2.7	
		2 ^{a,b}	
		1.3 ^{a,b}	
Thermal Resistance, Junction- to-Ambient ^{a,c}	$R_{\theta JA}$	62.5	°C/W
Thermal Resistance, Junction- to-Foot	Steady State	30	
Junction Temperature	T_J	150	°C
Junction Storage Temperature Range	T_{stg}	-55 to 150	

Notes: 1. Surface mounted on 1" x 1" FR4 board.

2. $t = 10 s$.

3. Maximum under steady state conditions is 110 °C/W.

4. Based on $T_c = 25^\circ C$.

P-Channel MOSFET

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■ Electrical Characteristics ($T_J = 25^\circ\text{C}$, unless otherwise noted)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Static						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{I}_D = -250\mu\text{A}, \text{V}_{\text{GS}} = 0\text{V}$	-60			V
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}} = -60\text{V}, \text{V}_{\text{GS}} = 0\text{V}$			-1	μA
		$\text{V}_{\text{DS}} = -60\text{V}, \text{V}_{\text{GS}} = 0\text{V}, \text{T}_J = 55^\circ\text{C}$			-5	
Gate-Body Leakage Current	I_{GSS}	$\text{V}_{\text{DS}} = 0\text{V}, \text{V}_{\text{GS}} = \pm 20\text{V}$			± 100	nA
On-State Drain Current ^a	$\text{I}_{\text{D}(\text{on})}$	$\text{V}_{\text{DS}} \geq -10\text{ V}, \text{V}_{\text{GS}} = -10\text{ V}$	-30			A
Gate Threshold Voltage	$\text{V}_{\text{GS}(\text{th})}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = -250\mu\text{A}$	-0.5		-2	V
Static Drain-Source On-Resistance ^a	$\text{R}_{\text{DS}(\text{on})}$	$\text{V}_{\text{GS}} = -10\text{V}, \text{I}_D = -3.5\text{A}$		50		$\text{m}\Omega$
		$\text{V}_{\text{GS}} = -4.5\text{V}, \text{I}_D = -2.8\text{A}$		60		
Forward Transconductance ^a	g_{fs}	$\text{V}_{\text{DS}} = -30\text{ V}, \text{I}_D = -3.5\text{ A}$		11		S
Dynamic ^b						
Input Capacitance	C_{iss}	$\text{V}_{\text{GS}} = 0\text{V}, \text{V}_{\text{DS}} = -30\text{V}, f = 1\text{MHz}$		832		pF
Output Capacitance	C_{oss}			88		
Reverse Transfer Capacitance	C_{rss}			63		
Total Gate Charge	Q_g	$\text{V}_{\text{DS}} = -30\text{ V}, \text{V}_{\text{GS}} = -10\text{V}, \text{I}_D = -3.5\text{ A}$		20	30	nC
				10.1	15.2	
Gate Source Charge	Q_{gs}	$\text{V}_{\text{DS}} = -30\text{ V}, \text{V}_{\text{GS}} = -4.5\text{V}, \text{I}_D = -3.5\text{ A}$		3.3		
Gate Drain Charge	Q_{gd}			3.9		
Gate Resistance	R_g	$f = 1\text{ MHz}$	1.8	9	18	Ω
Turn-On Delay Time	$\text{t}_{\text{d}(\text{on})}$	$\text{V}_{\text{DD}} = -30\text{ V}, \text{R}_L = 10.7\ \Omega, \text{I}_D = -2.8\text{ A}, \text{V}_{\text{GEN}} = -10\text{ V}, \text{R}_g = 1\Omega$		8	16	ns
Turn-On Rise Time	t_r			6	12	
Turn-Off Delay Time	$\text{t}_{\text{d}(\text{off})}$			35	53	
Turn-Off Fall Time	t_f			16	24	
Turn-On Delay Time	$\text{t}_{\text{d}(\text{on})}$	$\text{V}_{\text{DD}} = -30\text{ V}, \text{R}_L = 10.7\ \Omega, \text{I}_D = -2.8\text{ A}, \text{V}_{\text{GEN}} = -4.5\text{V}, \text{R}_g = 1\Omega$		40	60	ns
Turn-On Rise Time	t_r			28	42	
Turn-Off Delay Time	$\text{t}_{\text{d}(\text{off})}$			31	47	
Turn-Off Fall Time	t_f			15	23	
Drain-Source Body Diode Characteristics						
Maximum Body-Diode Continuous Current	I_s	$\text{T}_C = 25^\circ\text{C}$			-3.5	A
Maximum Body-Diode Pulsed Current	I_{SM}				-20	
Diode Forward Voltage	V_{SD}	$\text{I}_s = -2.8\text{A}, \text{V}_{\text{GS}} = 0\text{V}$		-0.85	-1.2	V
Body Diode Reverse Recovery Time	trr	$\text{I}_F = -2.8\text{ A}, \frac{d\text{I}}{dt} = 100\text{ A}/\mu\text{s}, \text{T}_J = 25^\circ\text{C}$		32	48	ns
Body Diode Reverse Recovery Charge	Qrr			45	68	nC
Reverse Recovery Fall Time	ta			24		ns
Reverse Recovery Rise Time	tb			8		

Notes a. Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$

b. Guaranteed by design, not subject to production testing.

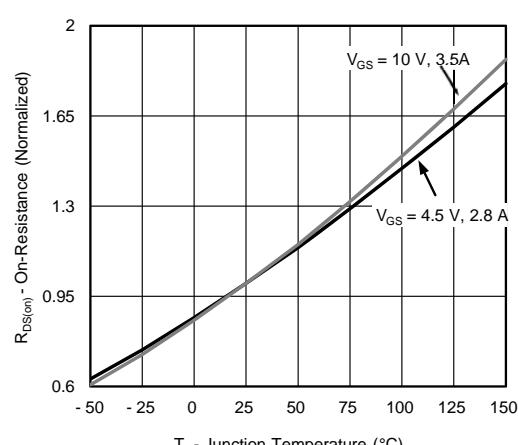
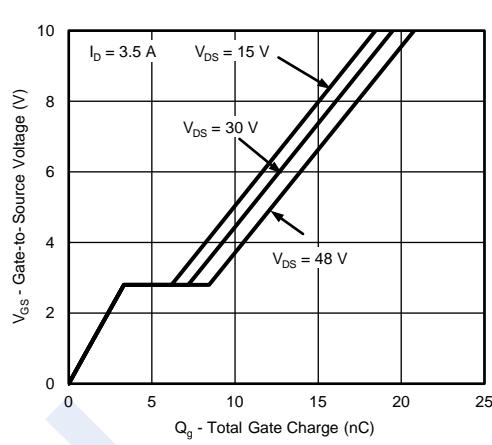
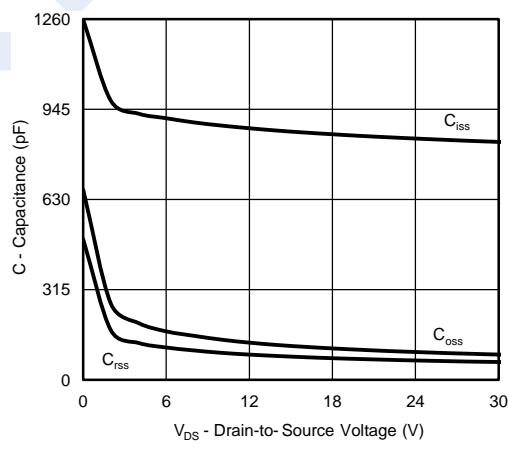
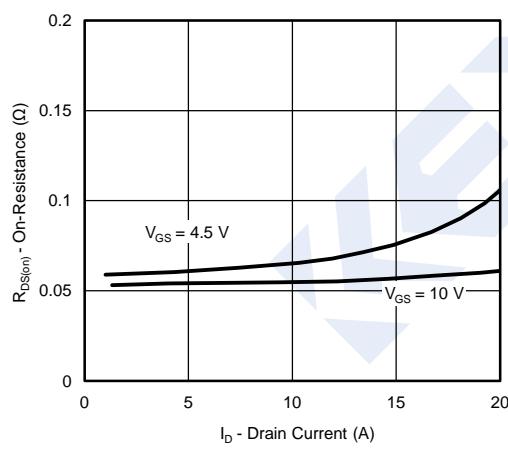
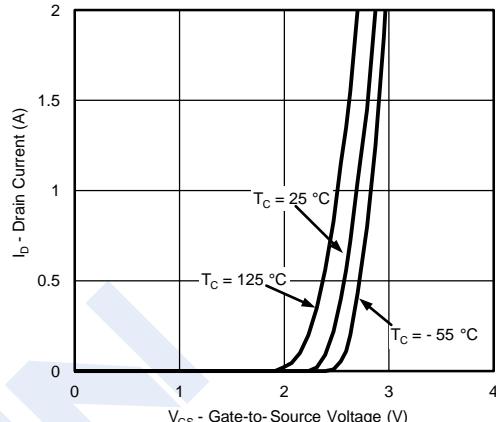
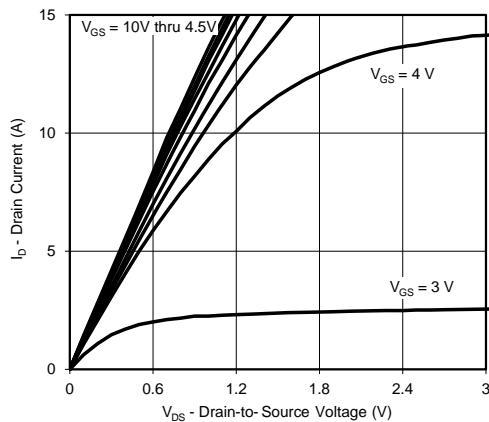
■ Marking

Marking	6068 *
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P-Channel MOSFET

2KJ6068

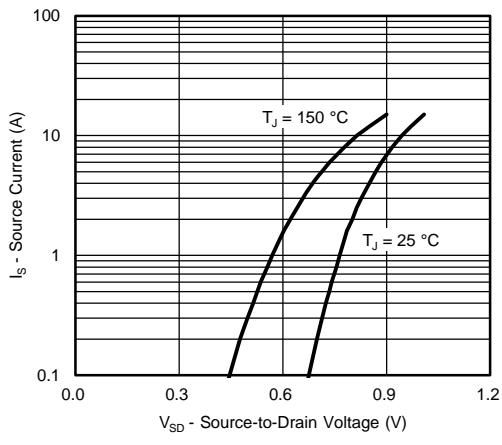
■ Typical Characteristics (25 °C, unless otherwise noted)



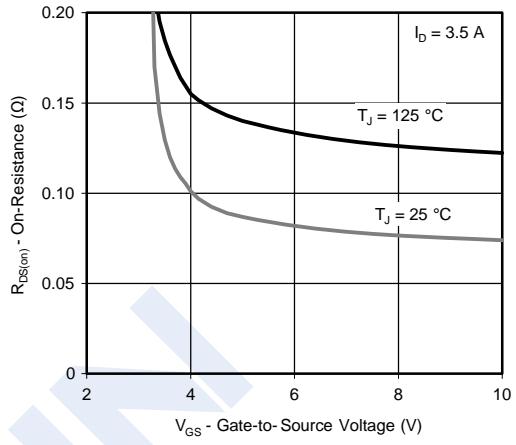
P-Channel MOSFET

2KJ6068

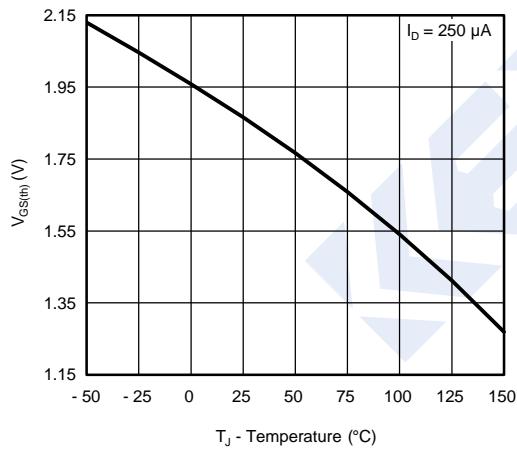
■ Typical Characteristics (25 °C, unless otherwise noted)



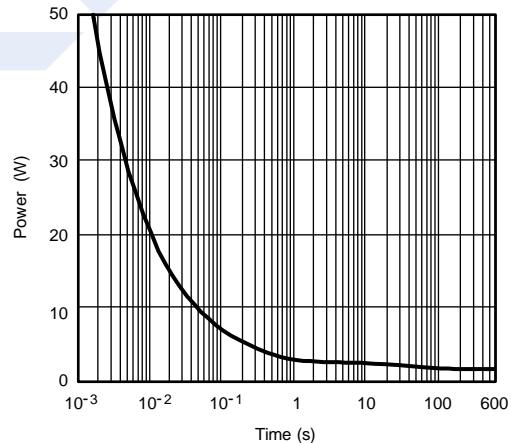
Source-Drain Diode Forward Voltage



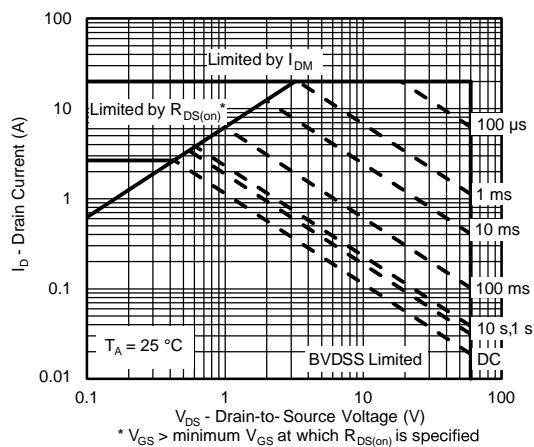
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient

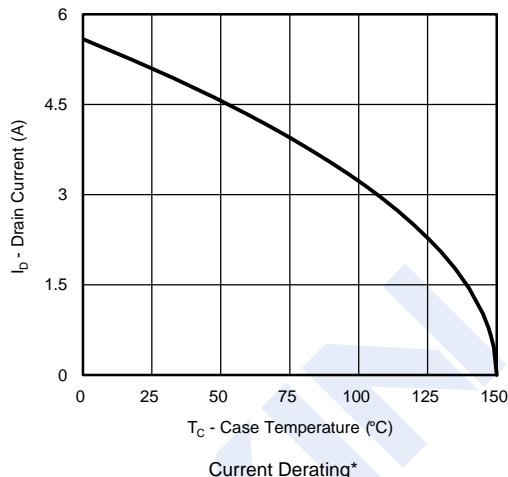


Safe Operating Area

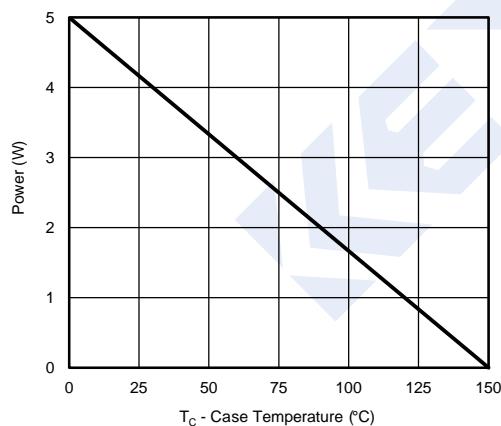
P-Channel MOSFET

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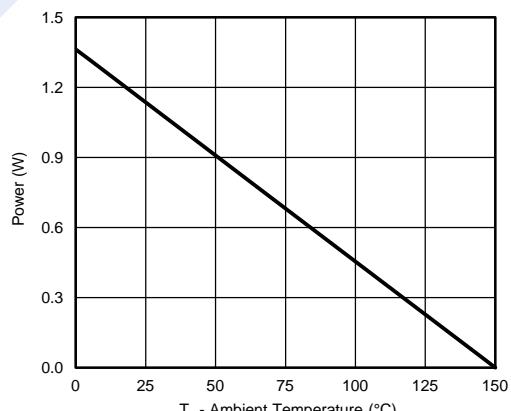
■ Typical Characteristics (25 °C, unless otherwise noted)



Current Derating*



Power, Junction-to-Foot



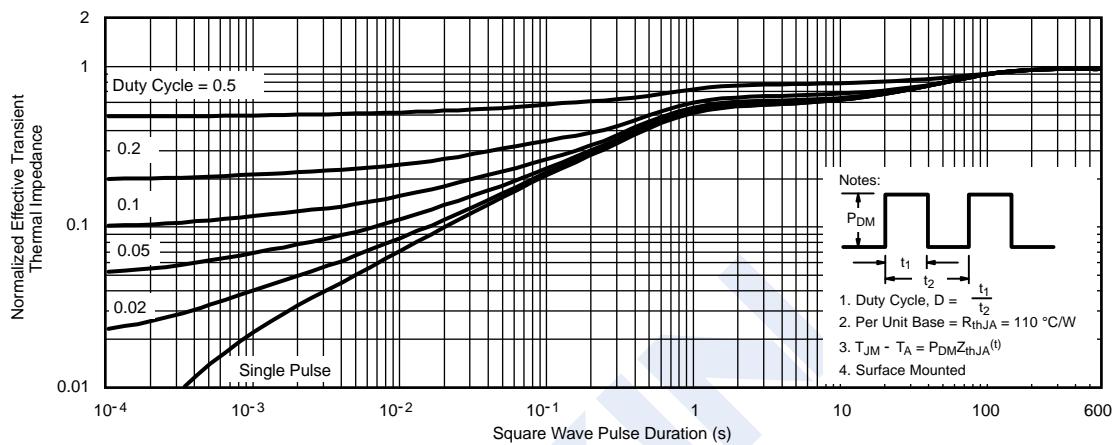
Power Derating, Junction-to-Ambient

* The power dissipation P_D is based on $T_J(\max.) = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

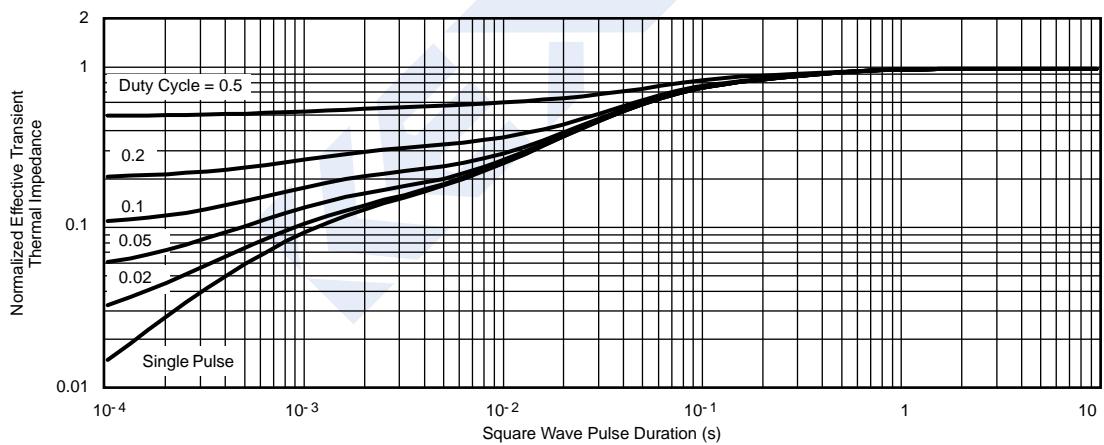
P-Channel MOSFET

2KJ6068

■ Typical Characteristics (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot